Deep Learning Crash Course

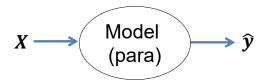


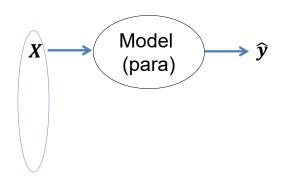
Hui Xue

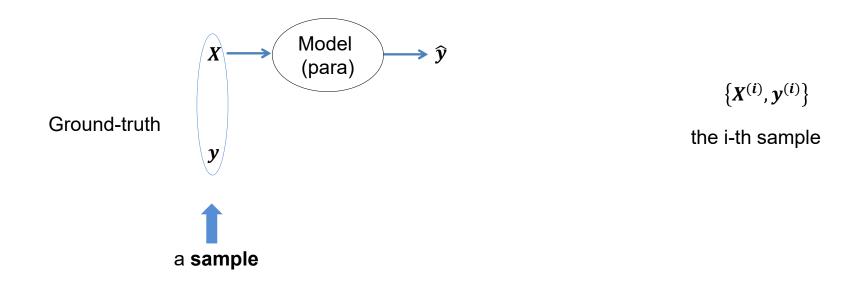
Fall 2021

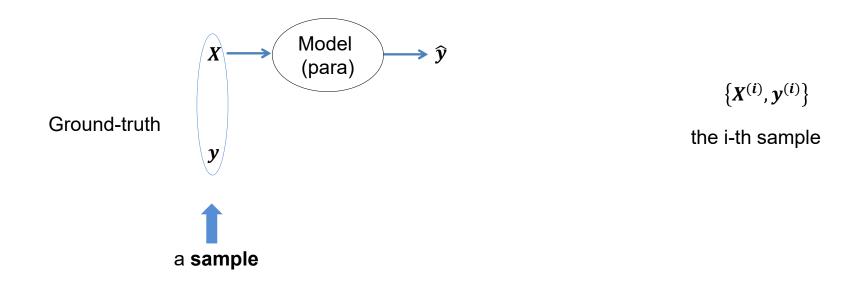
Outline

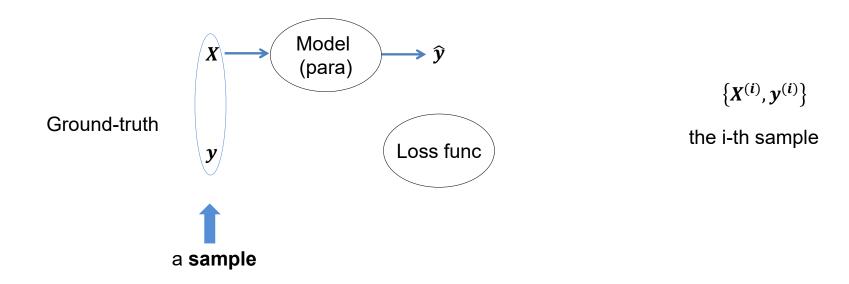
- Loss function for classification
- Gradient descent
- Bias and variance

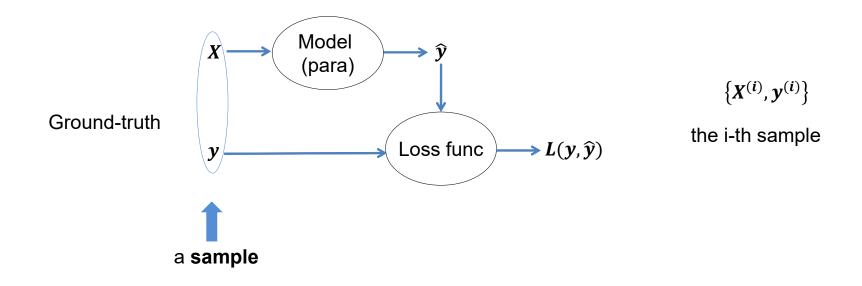












Cross-entropy

Given two probability distribution p and q, p is the target distribution and p is the model predicted distribution:

$$H(p,q) = -\sum_{\text{for all possible } x} p(x) log[q(x;\theta)]$$

- Measure how close two distributions are (not 100% rigorous)
- Minimized if p=q

$$H(p,q) = H(p) + D_{KL}(p \parallel q)$$

 $D_{KL}(p \parallel q)$ is the KL divergence of p and q.

$$D_{KL}(p \parallel q) \geq 0$$

 $D_{KL}(p \parallel q) = 0$ if and only if p=q

H(p) is the entropy of distribution p $H(p,q) \neq H(q,p)$

$$H(p,q) = -\sum_{x} p(x) \log[q(x)]$$

$$= -\sum_{x} p(x) \log\left[\frac{p(x)}{p(x)}q(x)\right]$$

$$= -\sum_{x} p(x) \left\{ \log[p(x)] + \log\left[\frac{q(x)}{p(x)}\right] \right\}$$

$$= -\sum_{x} p(x) \log[p(x)] - \sum_{x} p(x) \log\left[\frac{q(x)}{p(x)}\right]$$

$$= -\sum_{x} p(x) \log[p(x)] + \sum_{x} p(x) \log\left[\frac{p(x)}{q(x)}\right]$$

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Binary Cross-entropy loss

For the binary classification,

y = 0 for the "Yes" class and 1 for the "No" class

 $\widehat{y} \in [0,1]$, probability belonging to the "Yes" class $1-\widehat{y}$ for the "No" class

Then, the cross entropy (in this case, the BCE loss) is:

$$L_{BCE\ loss}(y,\widehat{y}) = -[y \cdot log(\widehat{y}) + (1-y) \cdot log(1-\widehat{y})]$$

To minimize the BCE loss,

if y = 0, $\hat{y} = 0$ will reach minimum of log(1)=0

if y = 1, $\hat{y} = 1$ will reach minimum of log(1)=0

For all other cases, $L_{BCE\ loss} > 0$

Cross-entropy loss for multi-class

For the multi-class classification,

$$y = \begin{cases} CH3, & 1 & 0 & 0 & 0 & 0 \\ CH2, & 0 & 1 & 0 & 0 & 0 \\ CH4, & 0 & 0 & 1 & 0 & 0 \\ SAX, & 0 & 0 & 0 & 1 & 0 \\ Other, & 0 & 0 & 0 & 0 & 1 \end{cases}$$

y is one-hot encoding for the correct class

$$y_k = \begin{cases} CH3, 0 \\ CH2, 1 \\ CH4, 2 \\ SAX, 3 \\ Other, 4 \end{cases}$$

 y_k is the index of correct class for sample y

 \hat{y} is a [K,1] vector for the probability of X belonging to each lass $\hat{y}[0]$ is a scalar to predict X being CH3 $\hat{y}[1]$ is a scalar to predict X being CH2 $\hat{y}[2]$ is a scalar to predict X being CH4

 $\hat{\mathbf{y}}[y_k]$ is a scalar to predict X being class y_k

Cross-entropy loss

For the multi-class classification,

$$L_{CE_loss}(y, \hat{y}) = -\sum_{k=0}^{4} y[k] \log(\hat{y}[k])$$

y is one-hot encoding for the correct class

$$L_{CE\ loss}(y, \widehat{y}) = -log(\widehat{y}[y_k])$$

 \hat{y} is a [K,1] vector for the probability of X being each lass

 $\hat{y}[y_k]$ is a scalar to predict X being class y_k

 y_k is the index of correct class for sample y



Only one term left!

To minimize the cross-entropy loss,

We need $\hat{y}[y_k] = 1$; for all other cases, $L_{CE \ loss} > 0$

Cross-entropy loss

	y
CH2	0
CH3	0
CH4	1
SAX	0
Other	0

$$L_{CE_loss}(y, \hat{y}) = -\sum_{k=0}^{4} y[k] \log(\hat{y}[k])$$

$$= -[0 \times \log(0.2) + 0 \times \log(0.3) + 1 \times \log(0.1) + 0 \times \log(0.15) + 0 \times \log(0.25)]$$

$$= -\log(0.1) = 2.3$$

Cross-entropy loss

	y
CH2	0
CH3	0
CH4	1
SAX	0
Other	0

$$L_{CE_loss}(y, \hat{y}) = -\sum_{k=0}^{4} y[k] \log(\hat{y}[k])$$

$$= -[0 \times \log(0.02)$$

$$+0 \times \log(0.1)$$

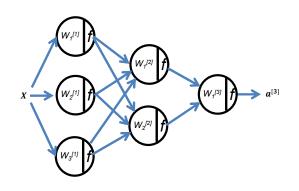
$$+1 \times \log(0.8)$$

$$+0 \times \log(0.05)$$

$$+0 \times \log(0.03)]$$

$$= -\log(0.8) = 0.22$$

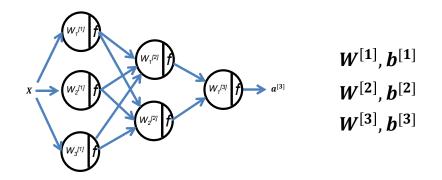
Where we are



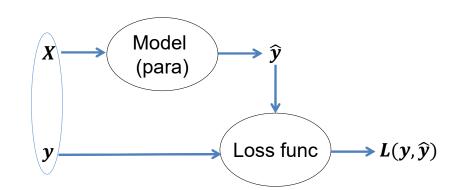
$$Z^{[1]} = W^{[1]}X + b^{[1]}$$
 $a^{[1]} = f(Z^{[1]})$
 $Z^{[2]} = W^{[2]}a^{[1]} + b^{[2]}$
 $a^{[2]} = f(Z^{[2]})$
 $L_{CE_loss}(y, \hat{y})$
 $L_{CE_loss}(y, \hat{y})$
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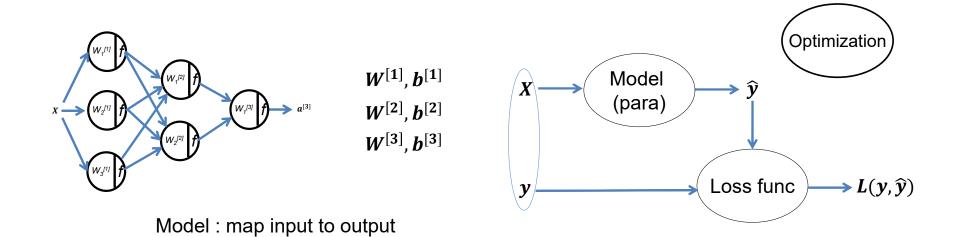
Model: map input to output

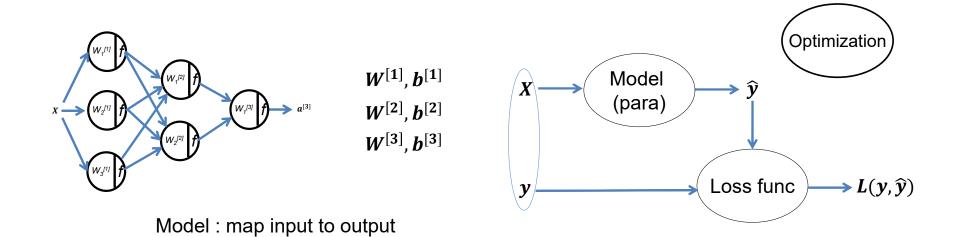
Loss: measure how good the output is, compared to the label

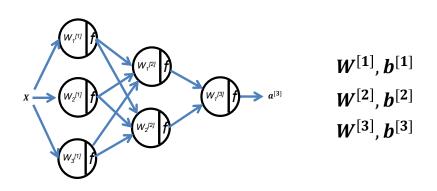


Model: map input to output

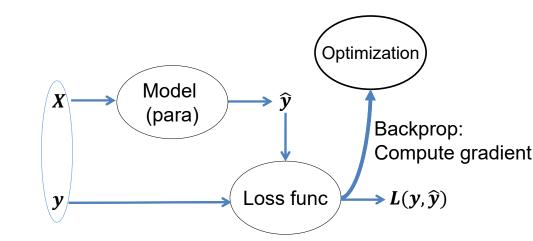


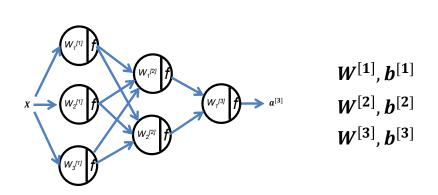




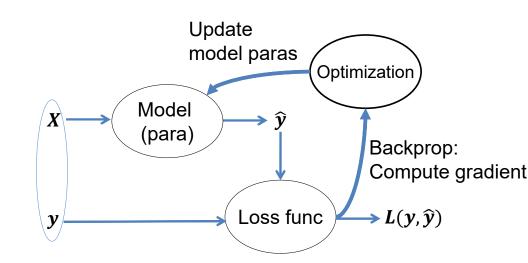


Model: map input to output

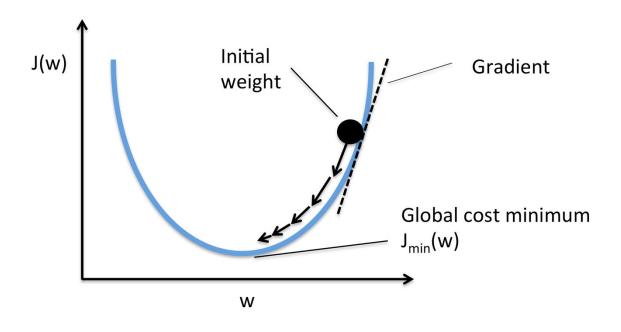




Model: map input to output



Gradient descent



To fine minimal point of a function

- Start from an initial point
- Follow the negative gradient direction

https://www.quora.com/Whats-the-difference-between-gradient-descent-and-stochastic-gradient-gra

Gradient of a function

Gradient of a function indicates the steepest direction to **increase** this function in a neighborhood. **Negative** gradient of a function indicates the steepest direction to **decrease** this function in a neighborhood.

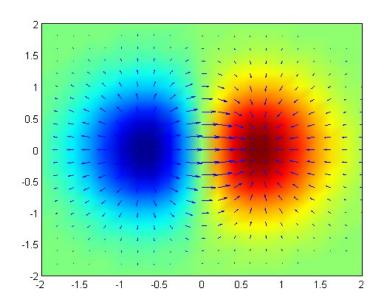
f is a scalar function.

In 1-dimension, the derivative of a function:

$$rac{df(x)}{dx} = \lim_{h o 0} rac{f(x+h) - f(x)}{h}$$

$$\nabla f(\boldsymbol{p}) = \begin{bmatrix} \frac{\partial f}{\partial x_0} \\ \frac{\partial f}{\partial x_1} \\ \vdots \\ \frac{\partial f}{\partial x_{N-1}} \end{bmatrix}$$

- $p = [x_0, x_1, x_2, ..., x_{N-1}]^T$ is a point in N-dimensional space
- ∇f(p) is the gradient at point p.
 Its direction points to the steepest slope to increase the function.
- The steepness of the slope at that point is given by the $|\nabla f(\mathbf{p})|$



https://en.wikipedia.org/wiki/Gradient#/media/File:Gradient_of_a_Function.tif

Gradient descent

Gradient direction

İS

the steepest direction to **increase** this function

We want to minimize the loss $L(y, \hat{y}(W, b))$ by adjusting the model parameters



For every layer l:

$$\mathbf{W}^{[l]} = \mathbf{W}^{[l]} - \alpha \frac{\partial \mathbf{L}(\mathbf{y}, \widehat{\mathbf{y}}(\mathbf{W}, \mathbf{b}))}{\partial \mathbf{W}^{[l]}}$$

$$\boldsymbol{b}^{[l]} = \boldsymbol{b}^{[l]} - \alpha \frac{\partial L(\boldsymbol{y}, \widehat{\boldsymbol{y}}(\boldsymbol{W}, \boldsymbol{b}))}{\partial \boldsymbol{b}^{[l]}}$$

 α : learning rate

Guarantee to find a local minima

Gradient Descent (GD) over a set of samples

We have M samples

Empirical loss on measured data =
$$\frac{1}{M}\sum_{i=0}^{M-1}L(\boldsymbol{y^{(i)}},\widehat{\boldsymbol{y}^{(i)}}(\boldsymbol{W},\boldsymbol{b}))$$

$$\frac{\partial L(y,\widehat{y}(W,b))}{\partial W^{[l]}} = \frac{1}{M} \sum_{i=0}^{M-1} \frac{\partial L(y^{(i)},\widehat{y}^{(i)}(W,b))}{\partial W^{[l]}}$$

Find best parameters to minimize the mean loss across all training samples

$$\frac{\partial L(y,\widehat{y}(W,b))}{\partial b^{[l]}} = \frac{1}{M} \sum_{i=0}^{M-1} \frac{\partial L(y^{(i)},\widehat{y}^{(i)}(W,b))}{\partial b^{[l]}}$$

Gradient descent

Initialize weights and bias

for iter in range(t):

Evaluate loss function (forward pass) over all samples

$$L = \frac{1}{M} \sum_{i=0}^{M-1} L(\boldsymbol{y}^{(i)}, \widehat{\boldsymbol{y}}^{(i)}(\boldsymbol{W}, \boldsymbol{b}))$$

Compute gradient

$$\frac{\partial L}{\partial \boldsymbol{W}^{[l]}}, \frac{\partial L}{\partial \boldsymbol{b}^{[l]}}$$

Update parameter

$$\mathbf{W}^{[l]} = \mathbf{W}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{W}^{[l]}}$$
$$\mathbf{b}^{[l]} = \mathbf{b}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{b}^{[l]}}$$

Stochastic Gradient Descent (SGD)

GD performs one parameter update step after going through entire training set

- →Slow if M is large
- → Gradient update may lack "exploration"

Initialize weights and bias

Random shuffle dataset

for epoch in range(E):

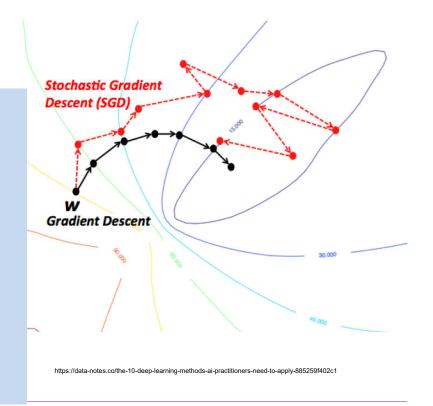
select one sample with index i

Evaluate loss function (forward pass) at this sample $L = L(\mathbf{v}^{(i)}, \widehat{\mathbf{v}}^{(i)}(\mathbf{W}, \mathbf{b}))$

$$L = L(\mathbf{y}^{(t)}, \mathbf{y}^{(t)}(\mathbf{W}, \mathbf{b}))$$

Compute gradient $\frac{\partial L}{\partial \boldsymbol{w}^{[l]}}, \frac{\partial L}{\partial \boldsymbol{b}^{[l]}}$

Update parameter $\mathbf{W}^{[l]} = \mathbf{W}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{W}^{[l]}}$, $\mathbf{b}^{[l]} = \mathbf{b}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{b}^{[l]}}$



Mini-Batch SGD

SGD can have too much "noise" during convergence Not fully utilize the computing hardware

Initialize weights and bias

Random shuffle dataset

BatchSize = 32

for epoch in range(E):

select #BatchSize samples

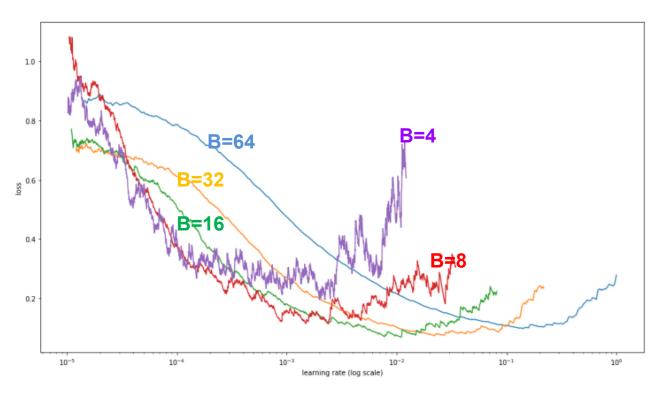
Evaluate loss function (forward pass) at this sample batch $L = \frac{1}{B} \sum_{i=0}^{B-1} L(\mathbf{y}^{(i)}, \hat{\mathbf{y}}^{(i)}(\mathbf{W}, \mathbf{b}))$

Compute gradient $\frac{\partial L}{\partial \boldsymbol{W}^{[l]}}, \frac{\partial L}{\partial \boldsymbol{b}^{[l]}}$

Update parameter
$$\mathbf{W}^{[l]} = \mathbf{W}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{W}^{[l]}}$$
, $\mathbf{b}^{[l]} = \mathbf{b}^{[l]} - \alpha \frac{\partial L}{\partial \mathbf{b}^{[l]}}$

- Batch size often is limited by the GPU RAM
- Different way to select a batch, e.g. sequential, random, fixed step size etc.

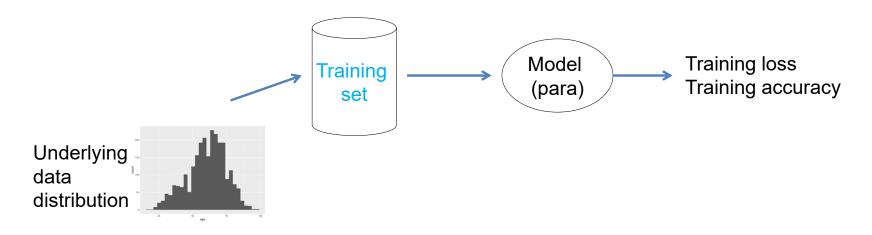
Larger batch size, higher learning rate



- Larger BatchSize, better estimation of gradient
- Larger BatchSize, less exploration
- High learning rate for small BatchSize can lead to failed convergence
- Overall, set BatchSize large, subject to the GPU RAM limit
- More on how to find good learning rate ...

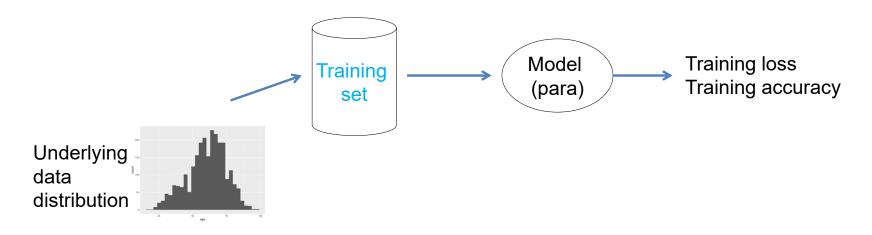
ttps://miquel-data-sc.github.io/2017-11-05-first/#:~:text=For%20the%20ones%20unaware%2C%20general,descent%20(batch%20size%201)

https://arxiv.org/abs/1506.01186



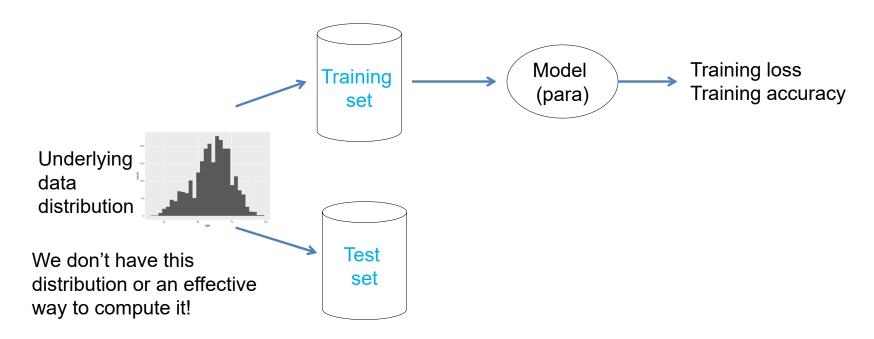
We don't have this distribution or an effective way to compute it!

- Training and test sets are sampled from the same distribution, i.i.d. (independent and identically distributed)
- We care test/generalization performance; that is, the performance of training model on a new dataset

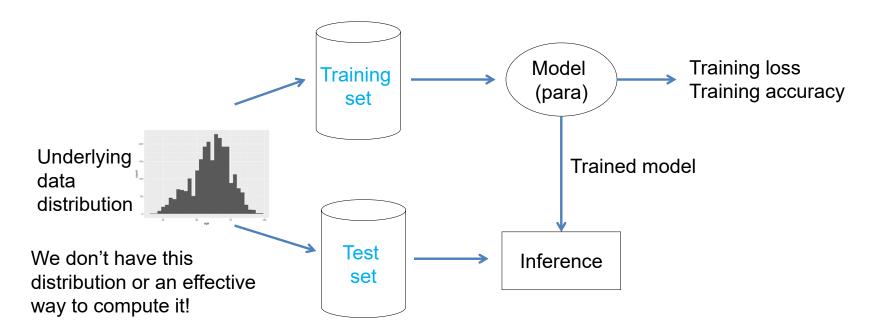


We don't have this distribution or an effective way to compute it!

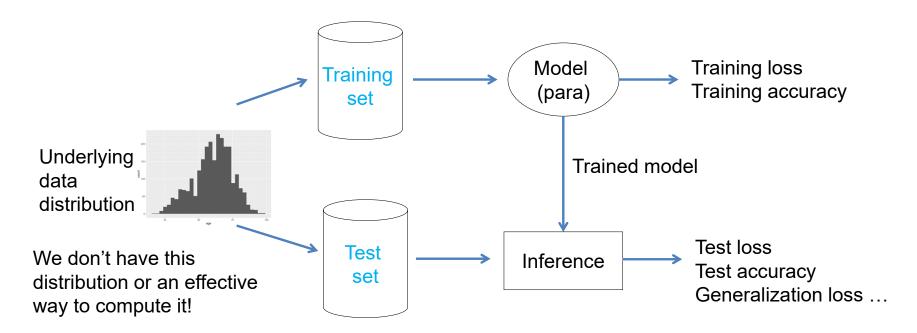
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Given the underlying function f(x), the model $M(x; \mathbf{D})$ to approximate f(x)

D is a data set sampled from function f(x). $D = [(x_0, y_0), (x_1, y_1), ..., (x_{N-1}, y_{N-1})]$

Every sample (x_i, y_i) is contaminated by noise: $y_i = f(x) + \epsilon$, ϵ is the random noise

We want to know the expected error of model, given the dataset D:

$$E_{\boldsymbol{D}}[(y - M(\boldsymbol{x}; \boldsymbol{D}))^2]$$

This error consists of three parts:

$$E_{\mathbf{D}}[(y - M(x; \mathbf{D}))^{2}] = \{E_{\mathbf{D}}[M(x; \mathbf{D})] - f(x)\}^{2} + E_{\mathbf{D}}[(E_{\mathbf{D}}(M(x; \mathbf{D})) - M(x; \mathbf{D}))^{2}] + \sigma^{2}$$

Model prediction error consists of three parts:

$$E_{\boldsymbol{D}}\left[\left(y - M(\boldsymbol{x}; \boldsymbol{D})\right)^{2}\right] = \left\{E_{\boldsymbol{D}}[M(\boldsymbol{x}; \boldsymbol{D})] - f(\boldsymbol{x})\right\}^{2} + E_{\boldsymbol{D}}\left[\left(E_{\boldsymbol{D}}(M(\boldsymbol{x}; \boldsymbol{D})) - M(\boldsymbol{x}; \boldsymbol{D})\right)^{2}\right] + \boldsymbol{\sigma}^{2}$$

 $Bias(\mathbf{M}, \mathbf{D}) = E_{\mathbf{D}}[M(\mathbf{x}; \mathbf{D})] - f(\mathbf{x})$ This is the **Bias**, for the difference between the mean model performance and ground-truth

 $E_{\mathbf{D}}[M(\mathbf{x}; \mathbf{D})]$ is the expected model performance over all possible datasets <- the best model we can get

Model prediction error consists of three parts:

$$E_{\boldsymbol{D}}\left[\left(y - M(\boldsymbol{x}; \boldsymbol{D})\right)^{2}\right] = \left\{E_{\boldsymbol{D}}[M(\boldsymbol{x}; \boldsymbol{D})] - f(\boldsymbol{x})\right\}^{2} + E_{\boldsymbol{D}}\left[\left(E_{\boldsymbol{D}}(M(\boldsymbol{x}; \boldsymbol{D})) - M(\boldsymbol{x}; \boldsymbol{D})\right)^{2}\right] + \boldsymbol{\sigma}^{2}$$

$$Var(\boldsymbol{M},\boldsymbol{D}) = E_{\boldsymbol{D}} \big[(E_{\boldsymbol{D}'} \big(M(\boldsymbol{x}; \boldsymbol{D}') \big) - M(\boldsymbol{x}; \boldsymbol{D}))^2 \big]$$

This is the **Variance**, measuring model performance fluctuation due to different datasets.

Measure how much the model prediction can change, after trained with different training sets

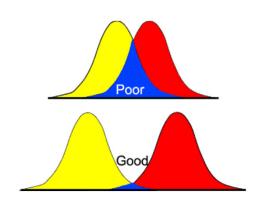
Model prediction error consists of three parts:

$$E_{\boldsymbol{D}}\left[\left(y-M(\boldsymbol{x};\boldsymbol{D})\right)^{2}\right]=\left\{E_{\boldsymbol{D}}[M(\boldsymbol{x};\boldsymbol{D})]-f(\boldsymbol{x})\right\}^{2}+E_{\boldsymbol{D}}\left[\left(E_{\boldsymbol{D}}(M(\boldsymbol{x};\boldsymbol{D}))-M(\boldsymbol{x};\boldsymbol{D})\right)^{2}\right]+\boldsymbol{\sigma}^{2}$$

 σ^2 Bayes error, irreducible error

lowest possible error rate for any classifier

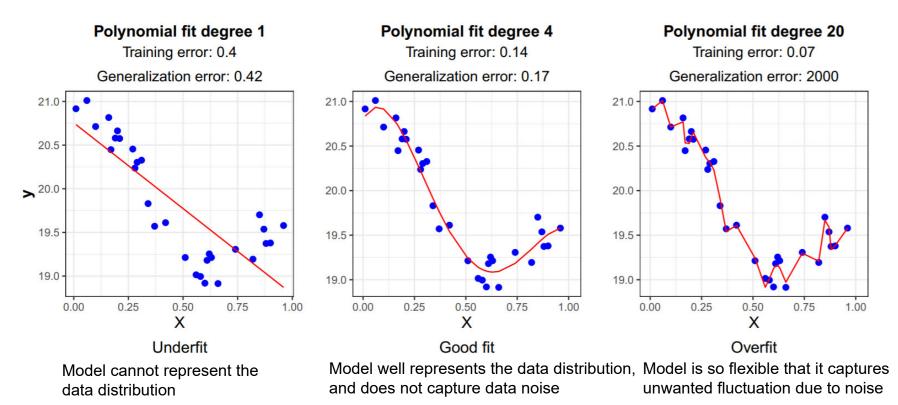
If one would know exactly what process/distribution generates the data, one still cannot achieve 100% accuracy, due to randomness



Distribution of two classes can overlap

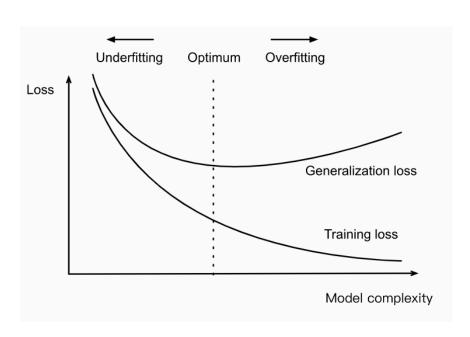
http://www.alanfielding.co.uk/multivar/dawords.htm

Underfitting and overfitting



https://ascpt.onlinelibrary.wiley.com/doi/10.1002/cpt.1796

Underfitting and overfitting



- Increasing model capacity/complexity can lead to overfitting
- When applying trained model to a new dataset, e.g. test set, model performance can decrease, as a result of overfitting, indicated by the high generalization loss
- Model can also underfitting the data, indicated by the high training loss

https://ja.d2l.ai/chapter_deep-learning-basics/underfit-overfit.html

In Deep Learning set up

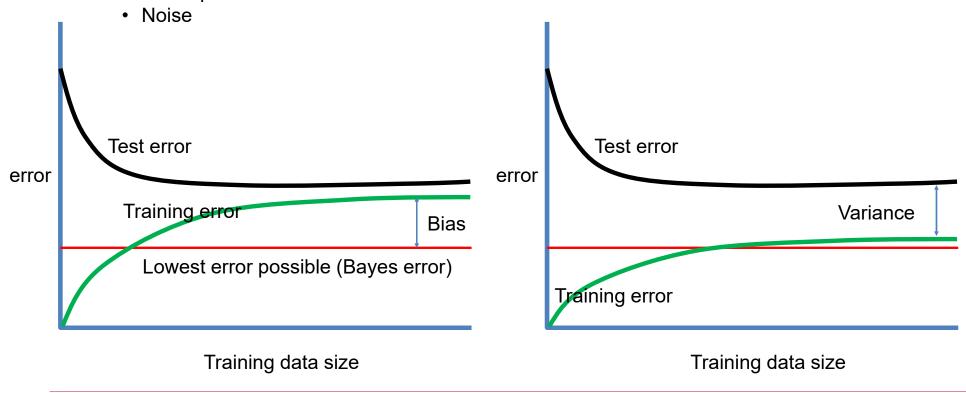


- We train on Training set and use training accuracy to estimate model performance ← Bias.
- We apply the trained model on Testing set. Performance difference between training accuracy and test accuracy gives an estimation of **Variance**.

Bias and variance

Bayes error is the best possible error rate if we knew true data distribution. It will not be zero:

• Overlap between class distribution



Regularization to control model complexity

Deep learning model is very powerful, that it may overfit training data → degraded generalization

IDEA: change loss function to control model complexity

$$L = \frac{1}{B} \sum_{i=0}^{B-1} L^{(i)} + \lambda R(\mathbf{W})$$

Data loss: how well model fits the data

Regularization loss: prevent model from fitting training data too well

L2 Regularization, weight decay

$$L = \frac{1}{B} \sum_{i=0}^{B-1} L^{(i)} + \frac{\lambda}{2} \| \mathbf{W} \|_{2}^{2}$$

$$\|\boldsymbol{W}\|_2^2 = \sum_{k=0}^{p-1} w_k^2$$
 For all parameters in the model, flatten them and computing the element-wise L2 norm

$$\frac{\partial L}{\partial w_k} = \frac{1}{B} \sum_{i=0}^{B-1} \frac{\partial L^{(i)}}{\partial w_k} + \lambda w_k \qquad w_k = w_k - \alpha (\frac{1}{B} \sum_{i=0}^{B-1} \frac{\partial L^{(i)}}{\partial w_k}) - \alpha \lambda w_k$$
 weight decay

L1 Regularization

$$L = \frac{1}{B} \sum_{i=0}^{B-1} L^{(i)} + \frac{\lambda}{2} \| \mathbf{W} \|_{1}$$

$$||W||_1 = \sum_{k=0}^{r-1} |w_k|$$
 For all parameters in the model, flatten them and computing the element-wise absolute value

$$\frac{\partial L}{\partial w_k} = \frac{1}{B} \sum_{i=0}^{B-1} \frac{\partial L^{(i)}}{\partial w_k} + \lambda sign(w_k) \qquad sign(w_k) = \begin{cases} 1, w_k > 0 \\ 0, w_k == 0 \\ -1, w_k < 0 \end{cases}$$

Drop Out

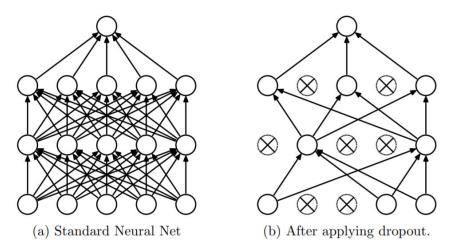


Figure 1: Dropout Neural Net Model. **Left**: A standard neural net with 2 hidden layers. **Right**: An example of a thinned net produced by applying dropout to the network on the left. Crossed units have been dropped.

Jointly train many smaller network, randomly selected

- Randomly drop out a set of neurons during training phase, with a probability of 1-p (e.g. p=0.5)
- It means to randomly select different rows in the W matrix, for every batch, every epoch
- During the test time, use all neurons, but scale the score by p
- Often used with linear layer, not for convolution
- · Require more epochs to train

Other operations with regularization effects

Regularization will:

- Increase training error
- Decrease testing error
- Introduce new hyper-parameters
- Often requires experiments

Other operations to improve test error:

- Data augmentation
- Drop connection, random connection
- Batch/Layer/Channel normalization
- Early stopping

. . .

More on this topic in later lecturers

